

FCC Verification

According to FCC Part 15

Applicant Name : SAMSUNG TECHWIN CO., LTD.

Address : #145-3, Sangdaewon 1-Dong, Jungwon-Gu,
Sunnam-Shi, Kyonggi-Do, Korea

Telephone : +82-31-740-8731

Declares that Product : CCD Camera

Model Name : SUD-2080FN

Report Number : 2010010056

This device complies with Part 15 of the FCC rules. Operations is subject to the following two conditions: (1) This device may not cause harmful interference, and (2) This device must accept any interference received, including interference that may cause undesired operation.

Test Laboratory:

CTK Co., Ltd.

386-1, Ho-Dong, Cheoin-gu, Yongin-si, Gyunggi-do, 449-100, Korea

Designation Number : KR0025

Tel : +82-31-339-9970

Fax : +82-31-339-9855

Responsible Party:

Company Name : _____

Company Address : _____

Phone : _____

Fax : _____

Name : _____

Signature : _____



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EMC TEST REPORT For FCC

Test Report No. : 2010010056

Date of Issue : January 19, 2010

Model/Type No. : SUD-2080FN

Kind of Product : CCD Camera

Applicant : SAMSUNG TECHWIN CO., LTD.

Applicant Address : #145-3, Sangdaewon 1-Dong, Jungwon-Gu, Sunnam-Shi,
Kyonggi-Do, Korea

Manufacturer : 1. SAMSUNG TECHWIN CO., LTD.
2. TIANJIN SAMSUNG TECHWIN OPTO-ELECTRONICS CO., LTD.

Manufacturer Address : 1. #42 Seongju-Dong, Changwon-Shi, Kyungsangnam-Do,
Korea
2. #No. 11 Wei Liu road Micro-electronic industrial park
Teda Tianjin China

Contact Person : Mr. Young-Soon, Choi (Manager)

Telephone : +82-31-740-8731

Received Date : December 22, 2009

Test Period : Start : December 23, 2009 End : December 29, 2009

Test Results : ☒ In Compliance ☐ Not in Compliance

The test results presented in this report relate only to the object tested.

Tested by

Hye-Young, Lee
EMC Test Engineer
Date: January 19, 2010

Reviewed by

James Hong
EMC Technical Manager
Date: January 19, 2010